Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/583,959	HAMZY ET AL.	
Examiner	Art Unit	
Jungwon Chang	2154	

SEARCHED				
Class	Subclass	Date	Examiner	
709	225	5/4/2005	JWC	
709	219	5/4/2005	JWC	
		·		
		·		
			_	
	,			

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
225	5/4/2005	JWC		
219	5/4/2005	JWC		
	Subclass 225	Subclass Date 225 5/4/2005		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East search NPL: Google ACM IEEE search report attached	5/4/2005	JWC
		-
	ä	